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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/716,113	COOKSON ET AL.	
Examiner	Art Unit	
TAN X. DINH	2627	

SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (see search history printout)	12/27/2006	T.D